

# Search Notes



Application/Control No.

10/727,465

Examiner

José V. Chen

Applicant(s)/Patent under  
Reexamination

SCHUTZ, UDO

Art Unit

3637

## SEARCHED

Class	Subclass	Date	Examiner
108	56.11 53.1 53.3 53.5	6/13/05	DL
206	386		
248	346.12		
206	600 599		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Front & Back CITATION FOR PERTINENT ART	6/16/05	DL